

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/553,452	<b>Applicant(s)/Patent under Reexamination</b> LE CREFF ET AL.
<b>Examiner</b> Quynh H. Nguyen	<b>Art Unit</b> 2614	

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
379	211.02 199 200	8/14/07	QN
370	522	8/14/07	QN
Interference searched history printout		8/14/07	QN